

2nd Request

PRINTER RUSH
(PTO ASSISTANCE)

Application : 10/066,851

Examiner : Ghyka

GAU : 2812

From: JIE

Location: IDC FMF FDC

Date: 11/01/04

Tracking #: 05920867

Week Date: 03/15/04

DOC CODE	DOC DATE	MISCELLANEOUS
<input checked="" type="checkbox"/> 1449	<u>02/04/2002</u>	<input type="checkbox"/> Continuing Data
<input type="checkbox"/> IDS		<input type="checkbox"/> Foreign Priority
<input type="checkbox"/> CLM		<input type="checkbox"/> Document Legibility
<input type="checkbox"/> IIFW		<input type="checkbox"/> Fees
<input type="checkbox"/> SRFW		<input type="checkbox"/> Other
<input type="checkbox"/> DRW		
<input type="checkbox"/> OATH		
<input type="checkbox"/> 312		
<input type="checkbox"/> SPEC		

[RUSH] MESSAGE: PTO 1449:

Please either initial or
line through citation(s).
(copies provided for reference).

Thank you

JIE

[XRUSH] RESPONSE: _____

INITIALS:

NOTE: This form will be included as part of the official USPTO record, with the Response document coded as XRUSH.

REV 10/04

INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO FORM 1449	Atty. Docket No. 10191/2092	Serial No. To Be Assigned
	Applicant(s) Frank FISCHER et al.	
	Filing Date Herewith	Group To Be Assigned

11017 U.S. PTO
 10/066851
 02/04/02

U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO
	DE 195 37 814	April 17, 1997	Fed. Rep. of Germany			X*	

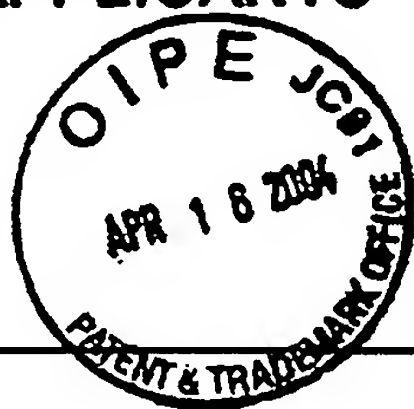
* Described in the Specification of the above-identified application.

OTHER DOCUMENTS

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	40 06 108	August 29, 1991	DE			Abstract	
	39 14 015	Oct. 31, 1990	DE			Abstract	

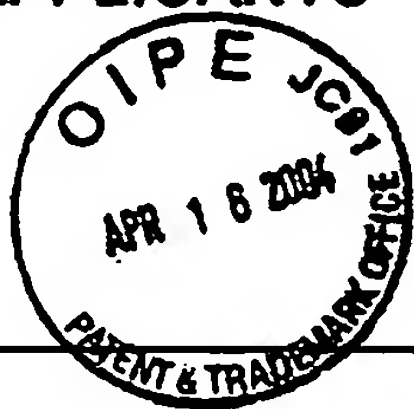
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EXAMINER'S INITIALS		AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
		L. B. Wilner, "A High Performance, Variable, Capacitance Accelerometer", IEEE Transactions On Instrumentation And Measurement, IEEE Inc., NY, US, Bd. 37, Nr. 4, 01.12.1988, pp. 569-571.

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	5,521,428	May 28, 1996	Hollingsworth et al.			

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		T. J. Brosnihan et al., 'Embedded Interconnect and Electrical Isolation For High-Aspect-Ratio, SOI Inertial Instruments, Transducers '07, 1997 International Conference on Solid-State Sensors and Actuators, Chicago, June 16-19, 1997, pp. 637-640.

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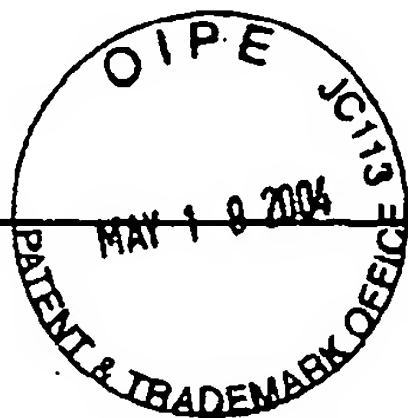
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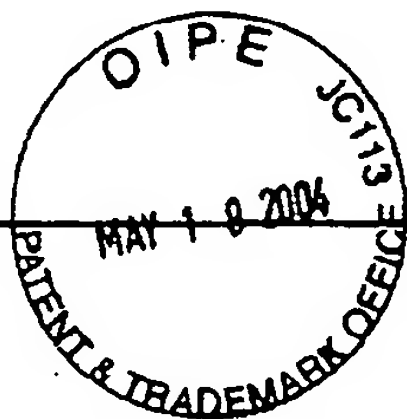
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